

FDD18N20LZ

February 2011 UniFET TM

N-Channel MOSFET 200V Logic, 16A, 0.125Ω

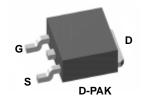
Features

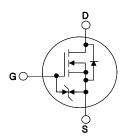
- $P_{DS(on)} = 0.125\Omega$ (Max.) @ $V_{GS} = 10V$, $I_D = 8A$
- · Low Gate Charge
- Low C_{ss}
- · Fast Switching
- 100% Avalanche Tested
- · Improved dv/dt Capability
- RoHS Compliant

Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advance technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switching mode power supplies and active power factor correction.





MOSFET Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted*

Symbol		Parameter		FDD18N20LZ	Units	
V _{DSS}	Drain to Source Voltage			200	V	
V _{GSS}	Gate to Source Voltage	Gate to Source Voltage		±20	V	
1	Drain Current	-Continuous (T _C = 25°C)		16	^	
ID	Drain Current	-Continuous (T _C = 100°C)		9.6	A	
I _{DM}	Drain Current	- Pulsed	- Pulsed (Note 1)		Α	
E _{AS}	Single Pulsed Avalanche E	nergy	(Note 2)	320	mJ	
I _{AR}	Avalanche Current		(Note 1)	16	Α	
E _{AR}	Repetitive Avalanche Ener	gy	(Note 1)	8.9	mJ	
dv/dt	Peak Diode Recovery dv/d	lt	(Note 3)	10	V/ns	
n	Dawer Dissination	$(T_C = 25^{\circ}C)$		89	W	
P_{D}	Power Dissipation	- Derate above 25°C		0.7	W/°C	
T _J , T _{STG}	Operating and Storage Ter	nperature Range		-55 to +150	°C	
T _L	Maximum Lead Temperatu 1/8" from Case for 5 Secon	<u> </u>		300	°C	

Thermal Characteristics

Symbol	Parameter FDD18N20LZ		
$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.4	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient 83		3C/VV

Package Marking and Ordering Information

	Device Marking	Device	Package	Reel Size	Tape Width	Quantity
ſ	FDD18N20LZ	FDD18N20LZ	D-PAK	380mm	16mm	2500

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	eteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A$, $V_{GS} = 0V$, $T_J = 25^{\circ}C$	200	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.2	-	V/°C
1	Zero Gate Voltage Drain Current	$V_{DS} = 200V, V_{GS} = 0V$	-	-	1	μА
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = 160V, T_{C} = 125^{\circ}C$	-	-	10	μΑ
I_{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 16V, V_{DS} = 0V$	-	-	±10	μΑ

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1.0	-	2.5	V
P	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 8A$		0.10	0.125	0
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 5V$, $I_D = 8A$	-	0.11	0.13	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = 20V, I_D = 2A$ (Note 4)	-	11	-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 25V V 20V	-	1185	1575	pF
C _{oss}	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V$		190	255	pF
C _{rss}	Reverse Transfer Capacitance	1 - 11/11/2	-	25	40	pF
Q _{g(tot)}	Total Gate Charge at 10V		-	30	40	nC
Q _{gs}	Gate to Source Gate Charge	$V_{DS} = 200 V I_{D} = 16 A$	-	3.5	-	nC
Q _{gd}	Gate to Drain "Miller" Charge	V _{GS} = 10V (Note 4, 5)	-	8.5	-	nC

Switching Characteristics

t _{d(on)}	Turn-On Delay Time			-	15	40	ns
t _r	Turn-On Rise Time	$V_{DD} = 100V, I_{D} = 16A$		-	20	50	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10V, R_G = 25\Omega$		-	135	280	ns
t _f	Turn-Off Fall Time		(Note 4, 5)	-	50	110	ns

Drain-Source Diode Characteristics

I _S	Maximum Continuous Drain to Source Diode Forward Current			-	-	16	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current			-	-	64	Α
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V$, $I_{SD} = 4A$		-	-	1.4	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0V$, $I_{SD} = 4A$		-	105	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	(Note 4)	-	0.4	-	μС

Notes

- Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 2.5mH, $\rm I_{AS}$ = 16A, $\rm V_{DD}$ = 50V, $\rm R_{G}$ = 25 Ω , Starting $\rm T_{J}$ = 25°C
- 3. $I_{SD} \le 16 A, \ di/dt \le 200 A/\mu s, \ V_{DD} \le BV_{DSS}, \ Starting \ T_J = 25^{\circ}C$
- 4. Pulse Test: Pulse Width $\leq 300~\mu\text{s},~\text{Duty Cycle} \leq 2.0\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

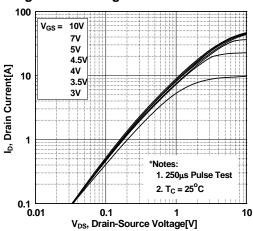


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

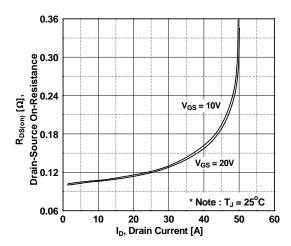


Figure 5. Capacitance Characteristics

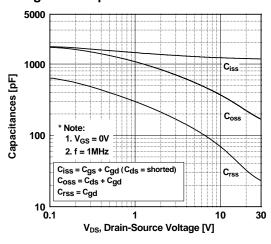


Figure 2. Transfer Characteristics

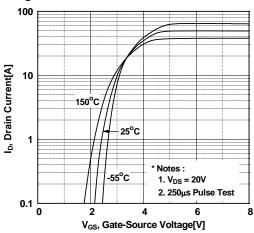


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

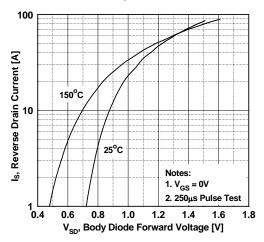
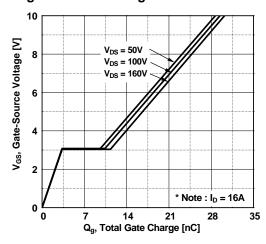


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

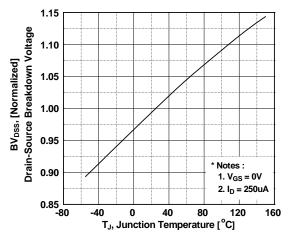


Figure 8. On-Resistance Variation vs. Temperature

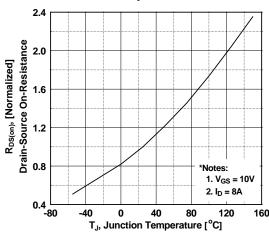


Figure 9. Maximum Safe Operating Area

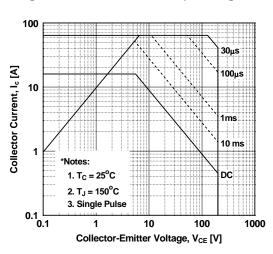


Figure 10. Maximum Drain Current vs. Case Temperature

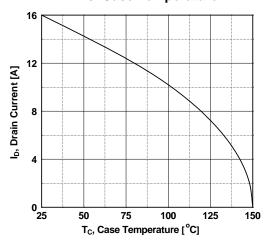
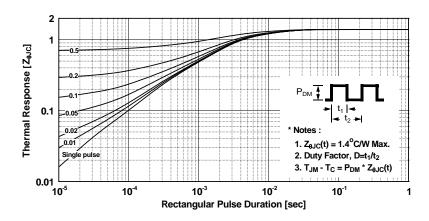
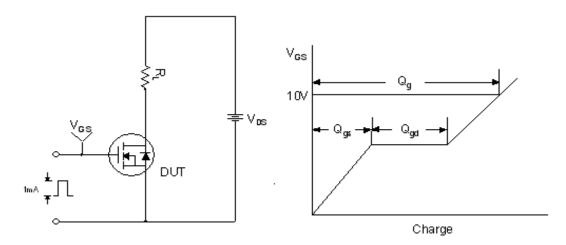


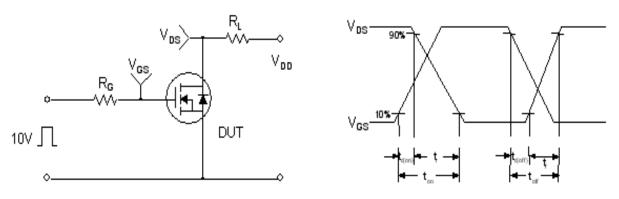
Figure 11. Transient Thermal Response Curve



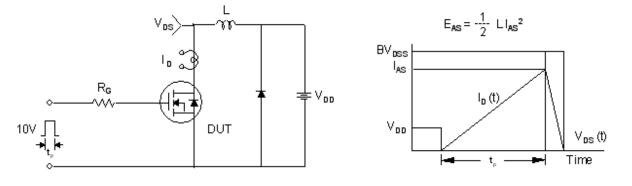
Gate Charge Test Circuit & Waveform



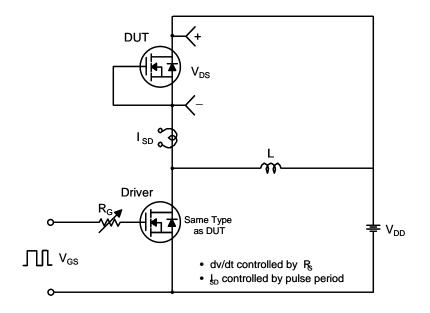
Resistive Switching Test Circuit & Waveforms

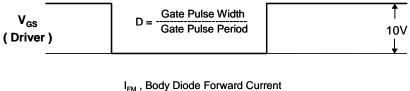


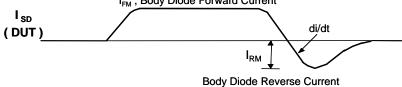
Unclamped Inductive Switching Test Circuit & Waveforms

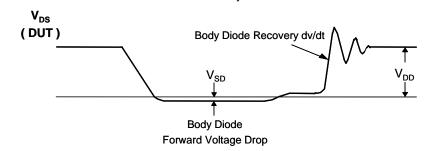


Peak Diode Recovery dv/dt Test Circuit & Waveforms



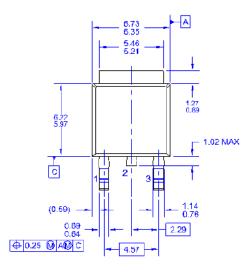


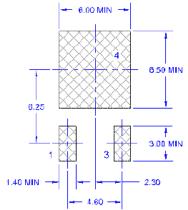




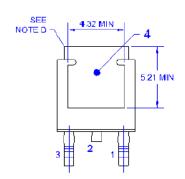
Mechanical Dimensions

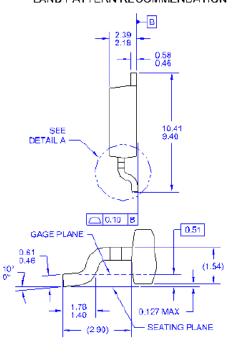
D-PAK





LAND PATTERN RECOMMENDATION





- NOTES: UNLESS OTHERWISE SPECIFIED

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 B) ALL DINENSIONS ARE IN MILLIMETERS.
 C) DINENSIONINS AND TOLENANCING PER ASME Y14-5M-1894.

 D) HEAT SINK TOP EDGE COULD BE IN CHAMFERED CORNERS OR EDGE FROTRUSION.

 E) PRESENCE OF TRIMMED CENTER LEAD IS OPTIONAL.

 F) DIMENSIONS ARE EXCLUSSIVE OF BRIRS, IVOLD FLASH AND THE BAR EX HRUSIONS.

 UNDER PATTERN RECOMENDATION 18 BASED ON IPC7351A STD TOJEOPTOOXX239-3N.

 H) DRAWING NUMBER AND REVISIONS WIKT-TOZSZAO3REVB

Dimensions in Millimeters





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